

## Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitances
- Easy to Parallel and Simple to Drive
- Avalanche Ruggedness
- Resistant to Latch-Up
- Halogen Free, RoHS Compliant

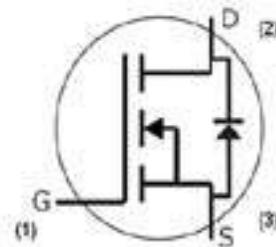
## Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

## Applications

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC converters
- Battery Chargers
- Motor Drive
- Pulsed Power Applications

## Package


**TO-247-3**


## Maximum Ratings ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
$V_{DS\max}$	Drain - Source Voltage	1200	V	$V_{GS} = 0 \text{ V}$ , $I_D = 100 \mu\text{A}$	
$V_{GS\max}$	Gate - Source Voltage	-10/+25	V	Absolute maximum values	
$V_{GSop}$	Gate - Source Voltage	-5/+20	V	Recommended operational values	
$I_D$	Continuous Drain Current	90	A	$V_{GS} = 20 \text{ V}$ , $T_c = 25^\circ\text{C}$	Fig. 19
		60		$V_{GS} = 20 \text{ V}$ , $T_c = 100^\circ\text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	250	A	Pulse width $t_p$ limited by $T_{j\max}$	Fig. 22
$P_D$	Power Dissipation	463	W	$T_c = 25^\circ\text{C}$ , $T_j = 150^\circ\text{C}$	Fig. 20
$T_j$ , $T_{stg}$	Operating Junction and Storage Temperature	-55 to +150	°C		
$T_L$	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s	
$M_d$	Mounting Torque	1 8.8	Nm lbf-in	M3 or 6-32 screw	

**Electrical Characteristics** ( $T_c = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	1200			V	$V_{\text{GS}} = 0 \text{ V}, I_D = 100 \mu\text{A}$	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	2.5	4	V	$V_{\text{DS}} = V_{\text{GS}}, I_D = 15 \text{ mA}$	Fig. 11
			1.8		V	$V_{\text{DS}} = V_{\text{GS}}, I_D = 15 \text{ mA}, T_J = 150^\circ\text{C}$	
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current		2	100	$\mu\text{A}$	$V_{\text{DS}} = 1200 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	
$I_{\text{GSS}}$	Gate-Source Leakage Current			600	nA	$V_{\text{GS}} = 20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	
$R_{\text{DS}(\text{on})}$	Drain-Source On-State Resistance		27	38	$\text{m}\Omega$	$V_{\text{GS}} = 20 \text{ V}, I_D = 50 \text{ A}$	Fig. 4,5,6
			37			$V_{\text{GS}} = 20 \text{ V}, I_D = 50 \text{ A}, T_J = 150^\circ\text{C}$	
$g_{\text{fs}}$	Transconductance		15.6		S	$V_{\text{DS}} = 20 \text{ V}, I_{\text{DS}} = 50 \text{ A}$	Fig. 7
			14.3			$V_{\text{DS}} = 20 \text{ V}, I_{\text{DS}} = 50 \text{ A}, T_J = 150^\circ\text{C}$	
$C_{\text{iss}}$	Input Capacitance		4700		pF	$V_{\text{GS}} = 0 \text{ V}$ $V_{\text{DS}} = 1000 \text{ V}$ $f = 1 \text{ MHz}$ $V_{\text{AC}} = 25 \text{ mV}$	Fig. 17,18
$C_{\text{oss}}$	Output Capacitance		231				
$C_{\text{rss}}$	Reverse Transfer Capacitance		42.8				
$E_{\text{oss}}$	$C_{\text{oss}}$ Stored Energy		121		$\mu\text{J}$		Fig 16
$E_{\text{AS}}$	Avalanche Energy, Single Pulse		2.6		J	$I_D = 50 \text{ A}, V_{\text{DD}} = 50 \text{ V}$	Fig. 29
$E_{\text{ON}}$	Turn-On Switching Energy		2.2		mJ	$V_{\text{DS}} = 800 \text{ V}, V_{\text{GS}} = -5/20 \text{ V}$ $I_D = 50 \text{ A}, R_{\text{G(ext)}} = 2.5 \Omega, L = 412 \mu\text{H}$	Fig. 25
$E_{\text{OFF}}$	Turn Off Switching Energy		0.5				
$t_{\text{d(on)}}$	Turn-On Delay Time		62		ns	$V_{\text{DD}} = 800 \text{ V}, V_{\text{GS}} = -5/20 \text{ V}$ $I_D = 50 \text{ A}, R_{\text{G(ext)}} = 2.5 \Omega, R_L = 16 \Omega$ Timing relative to $V_{\text{DS}}$ Per IEC60747-8-4 pg 83	Fig. 27
$t_r$	Rise Time		93				
$t_{\text{d(off)}}$	Turn-Off Delay Time		60				
$t_f$	Fall Time		39				
$R_{\text{G(int)}}$	Internal Gate Resistance		0.8		$\Omega$	$f = 1 \text{ MHz}, V_{\text{AC}} = 25 \text{ mV}, \text{ESR of } C_{\text{iss}}$	
$Q_{\text{gs}}$	Gate to Source Charge		58		nC	$V_{\text{DS}} = 800 \text{ V}, V_{\text{GS}} = -5/20 \text{ V}$ $I_D = 50 \text{ A}$ Per IEC60747-8-4 pg 83	Fig. 12
$Q_{\text{gd}}$	Gate to Drain Charge		90				
$Q_g$	Total Gate Charge		185				

**Reverse Diode Characteristics**

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions		Note
$V_{\text{SD}}$	Diode Forward Voltage	3.6		V	$V_{\text{GS}} = -5 \text{ V}, I_{\text{SD}} = 25 \text{ A}$		Fig. 8, 9, 10
		3.4		V	$V_{\text{GS}} = -5 \text{ V}, I_{\text{SD}} = 25 \text{ A}, T_J = 150^\circ\text{C}$		
$I_s$	Continuous Diode Forward Current		90		$T_c = 25^\circ\text{C}$		Note 1
$t_{rr}$	Reverse Recovery Time	45		ns	$V_{\text{GS}} = -5 \text{ V}, I_{\text{SD}} = 50 \text{ A}, T_J = 25^\circ\text{C}$ $VR = 800 \text{ V}$ $dif/dt = 1000 \text{ A}/\mu\text{s}$		Note 1
$Q_{rr}$	Reverse Recovery Charge	406		nC			
$I_{rrm}$	Peak Reverse Recovery Current	13.5		A			

Note (1): When using SiC Body Diode the maximum recommended  $V_{\text{GS}} = -5 \text{ V}$ 
**Thermal Characteristics**

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions		Note
$R_{\theta\text{JC}}$	Thermal Resistance from Junction to Case	0.24	0.27	$^\circ\text{C}/\text{W}$			Fig. 21
$R_{\theta\text{JA}}$	Thermal Resistance from Junction to Ambient		40				

## Typical Performance

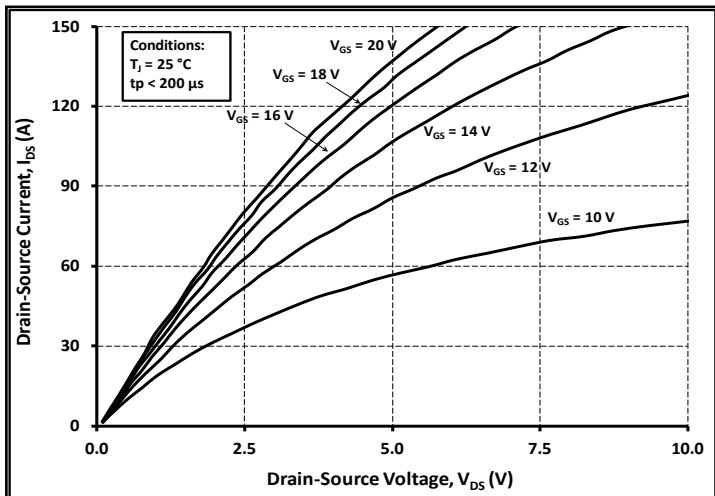
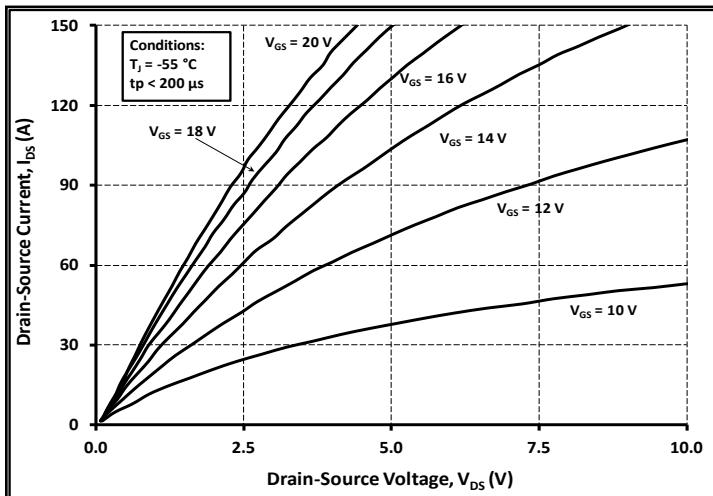


Figure 1. Output Characteristics  $T_J = -55\text{ }^{\circ}\text{C}$

Figure 2. Output Characteristics  $T_J = 25\text{ }^{\circ}\text{C}$

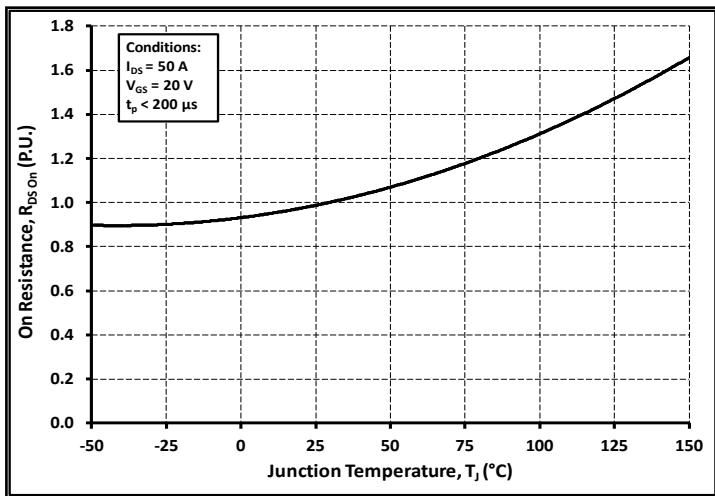
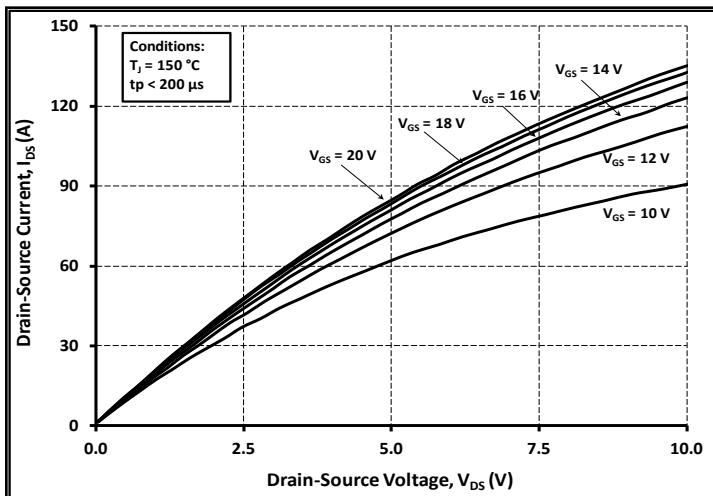


Figure 3. Output Characteristics  $T_J = 150\text{ }^{\circ}\text{C}$

Figure 4. Normalized On-Resistance vs. Temperature

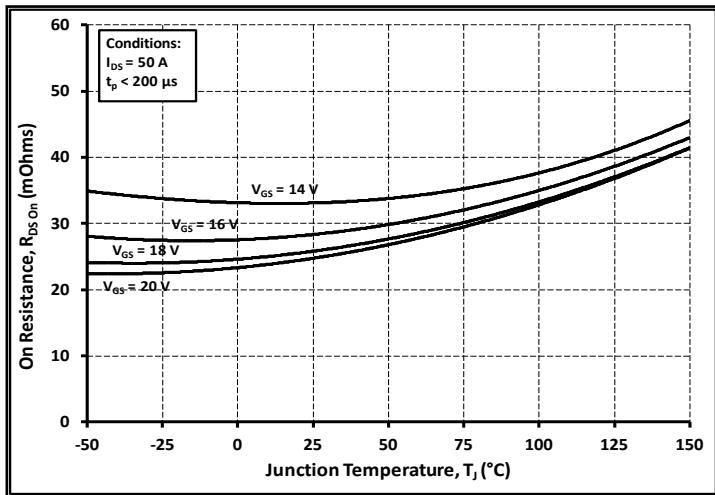
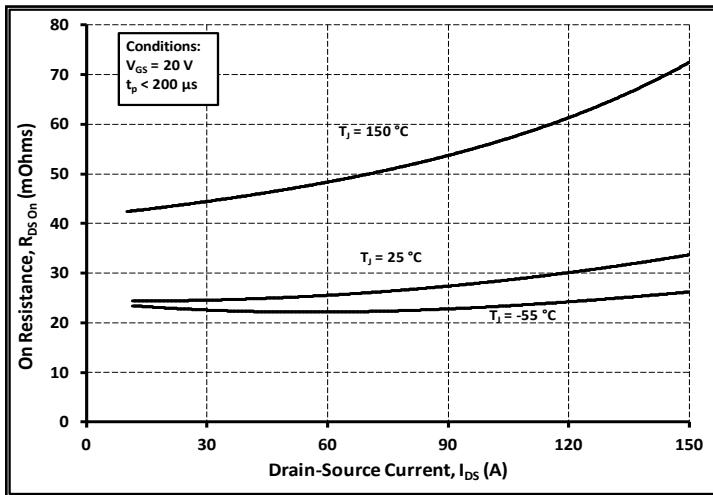


Figure 5. On-Resistance vs. Drain Current  
For Various Temperatures

Figure 6. On-Resistance vs. Temperature  
For Various Gate Voltage

## Typical Performance

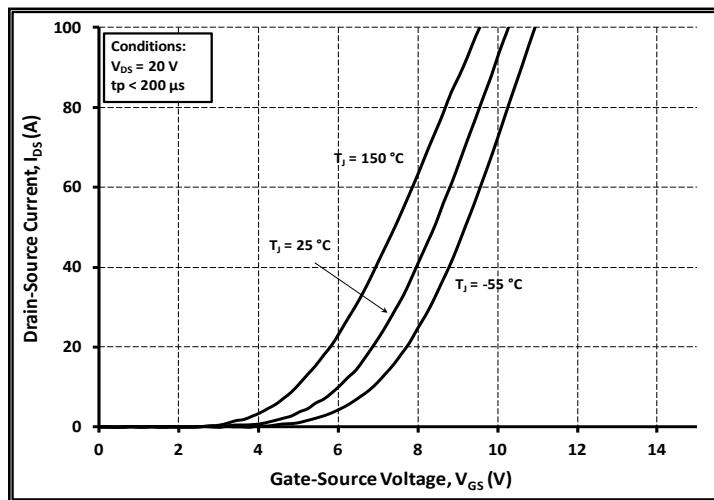


Figure 7. Transfer Characteristic For Various Junction Temperatures

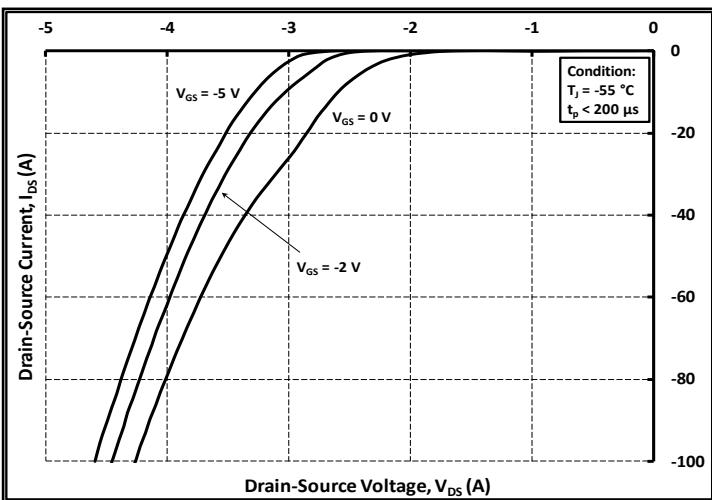


Figure 8. Body Diode Characteristic at  $-55^\circ\text{C}$

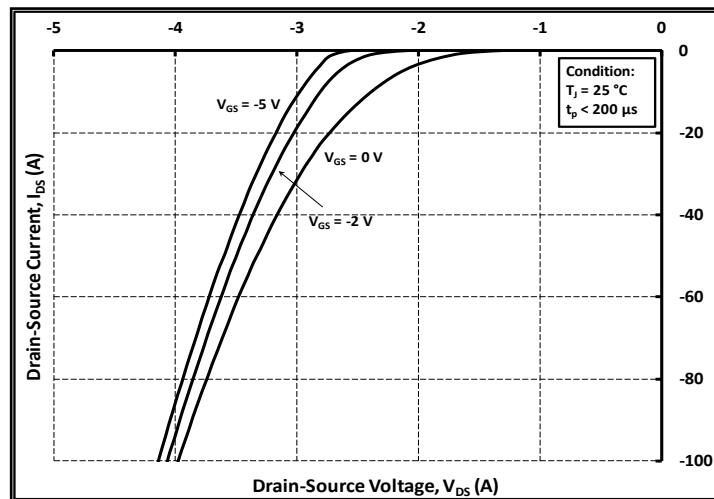


Figure 9. Body Diode Characteristic at  $25^\circ\text{C}$

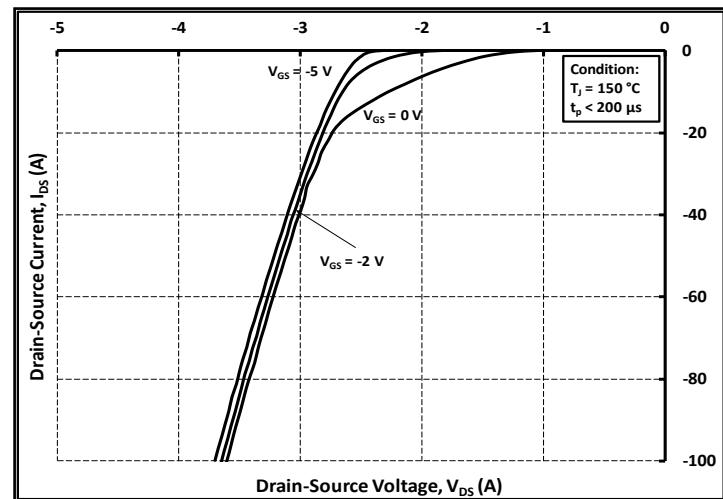


Figure 10. Body Diode Characteristic at  $150^\circ\text{C}$

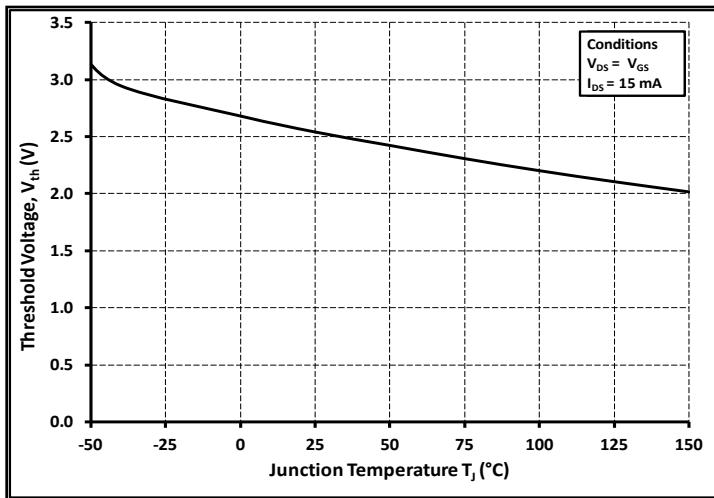


Figure 11. Threshold Voltage vs. Temperature

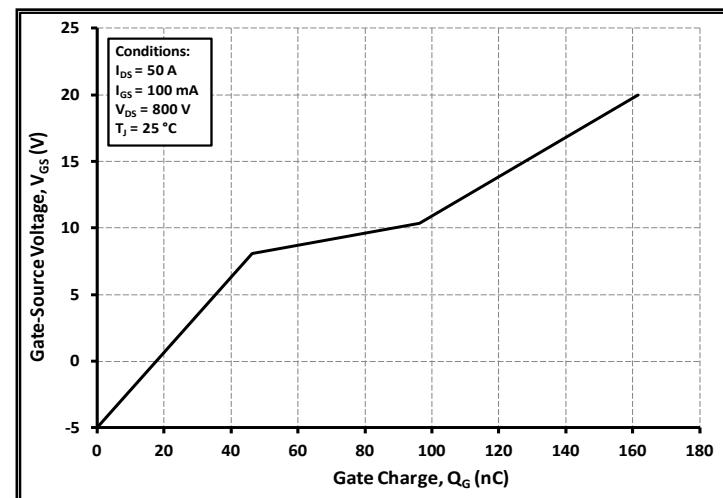


Figure 12. Gate Charge Characteristic

## Typical Performance

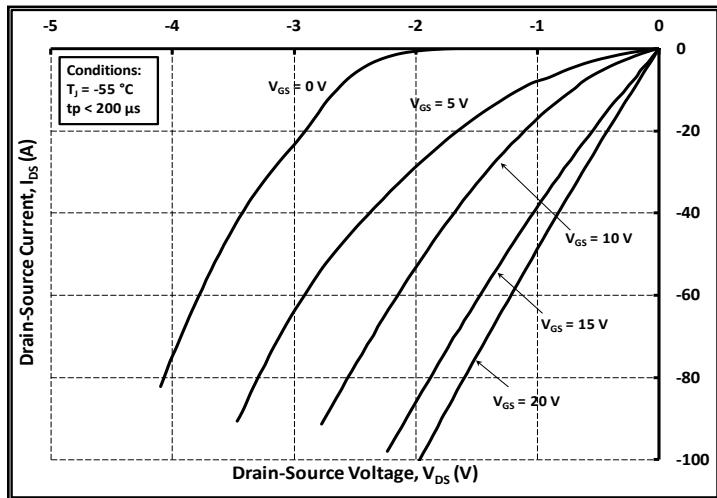


Figure 13. 3rd Quadrant Characteristic at  $-55^{\circ}\text{C}$

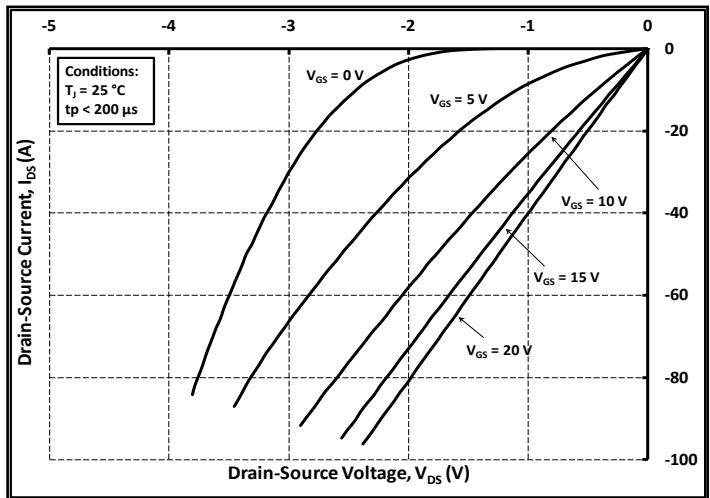


Figure 14. 3rd Quadrant Characteristic at  $25^{\circ}\text{C}$

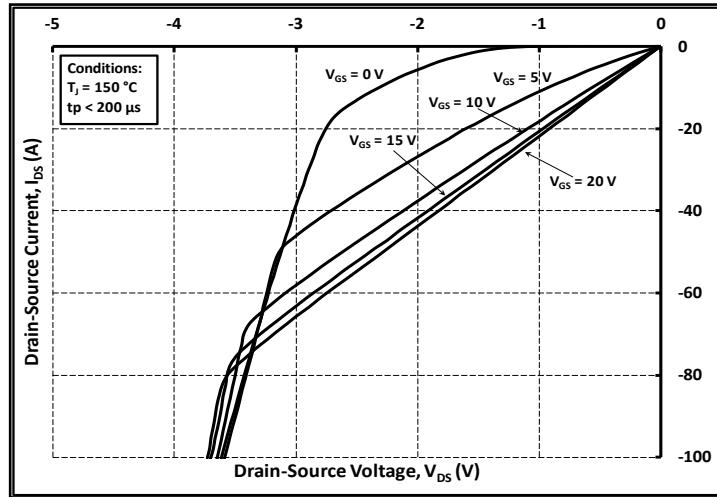


Figure 15. 3rd Quadrant Characteristic at  $150^{\circ}\text{C}$

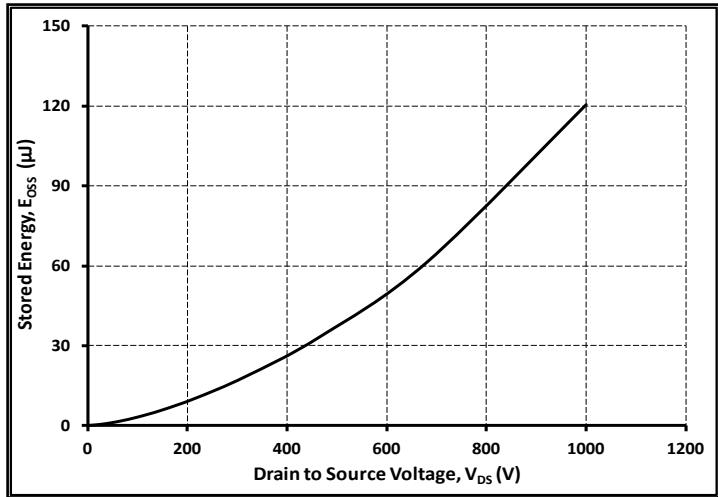


Figure 16. Output Capacitor Stored Energy

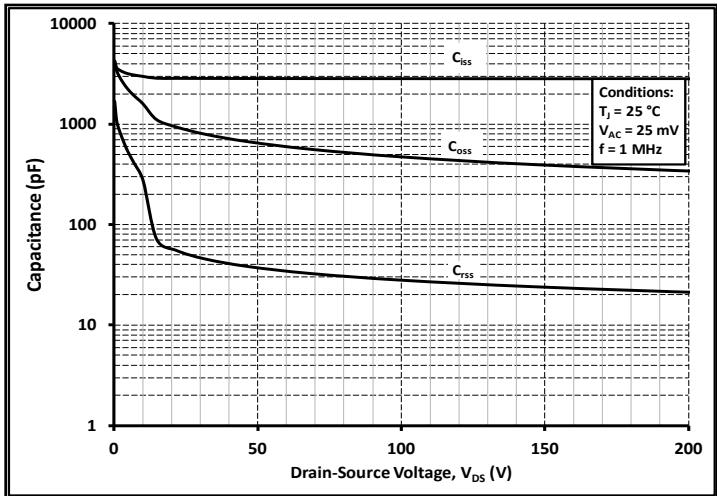


Figure 17. Capacitances vs. Drain-Source Voltage (0-200 V)

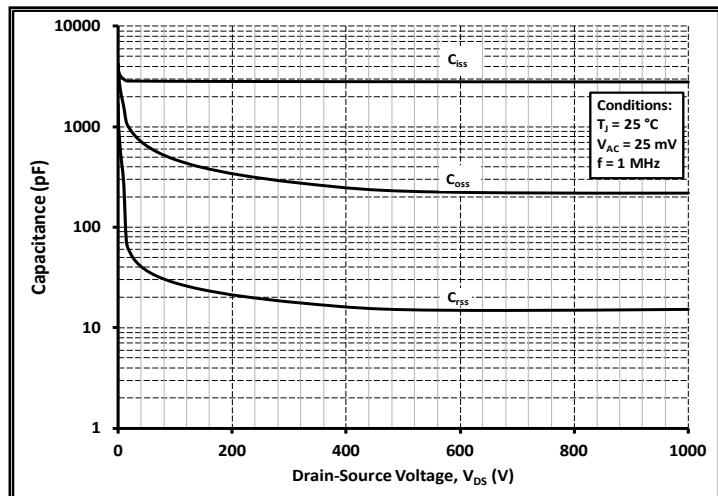
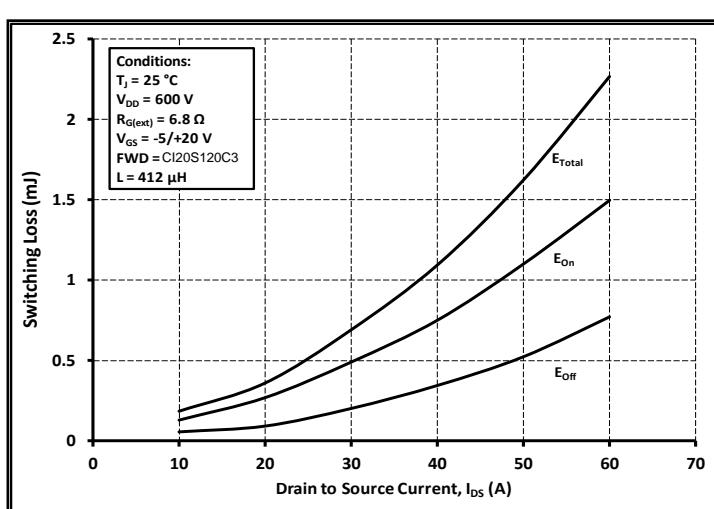
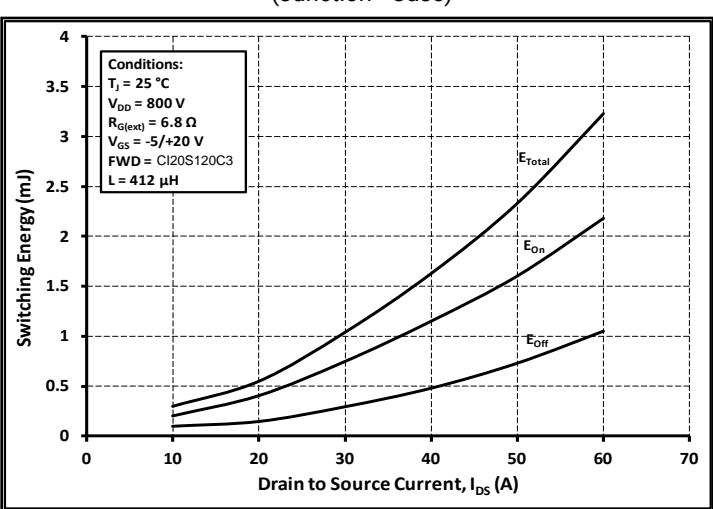
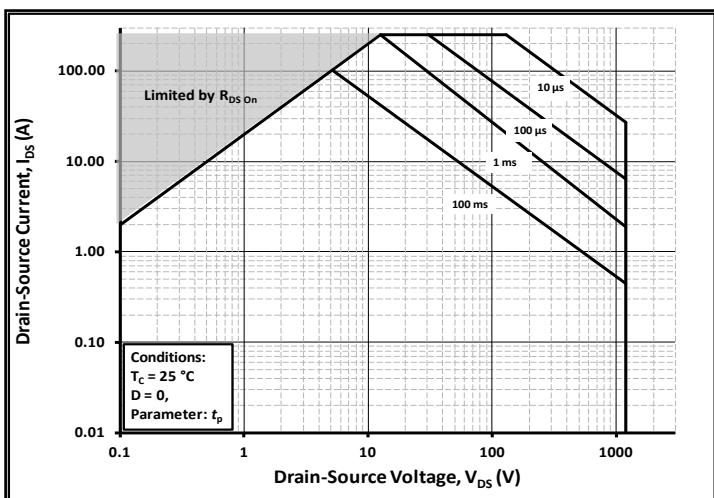
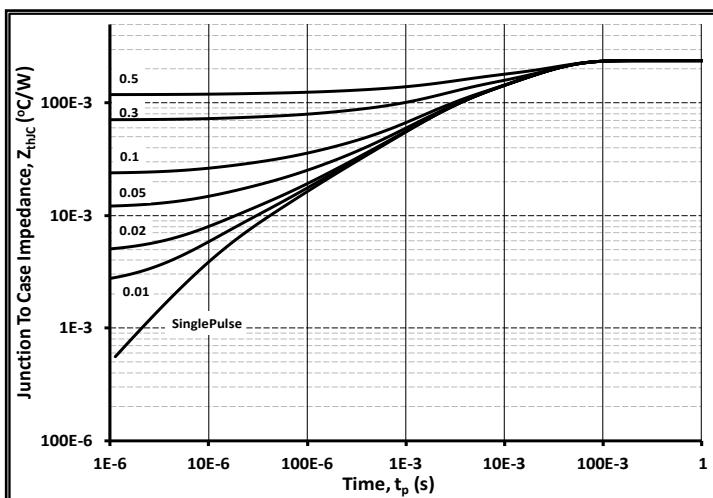
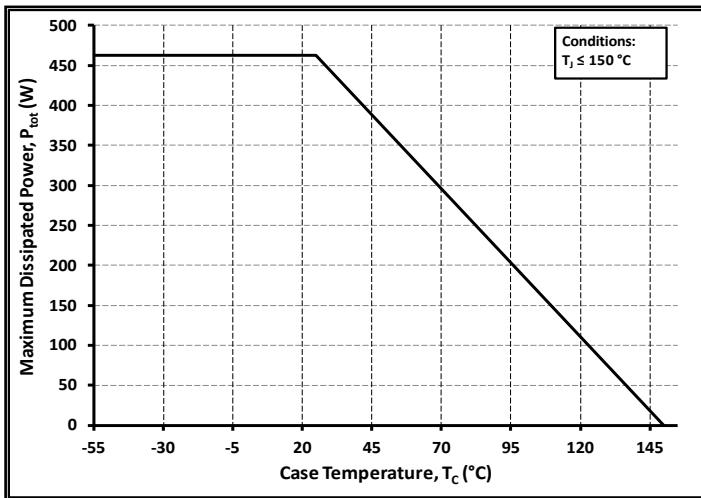
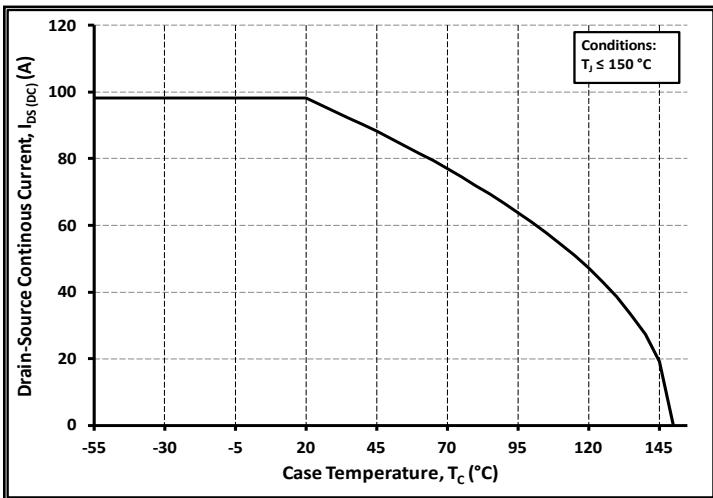


Figure 18. Capacitances vs. Drain-Source Voltage (0-1000 V)

## Typical Performance



## Typical Performance

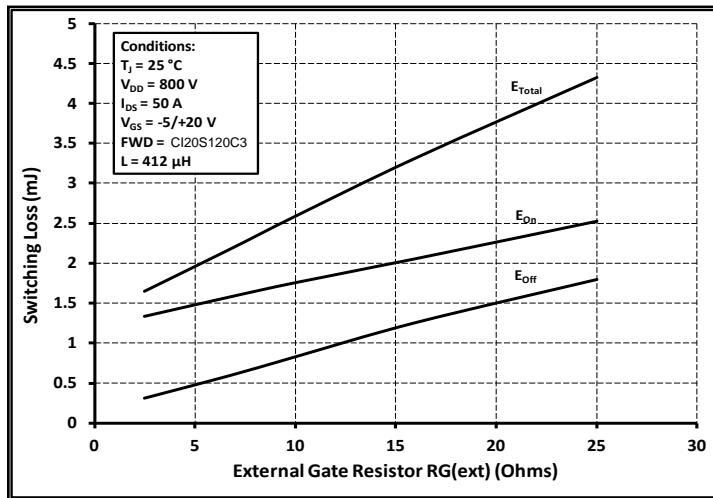


Figure 25. Clamped Inductive Switching Energy vs.  $R_{G(\text{ext})}$

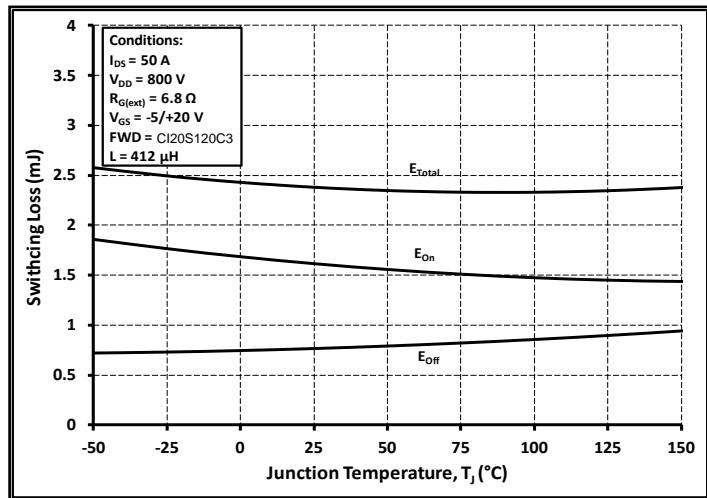


Figure 26. Clamped Inductive Switching Energy vs. Temperature

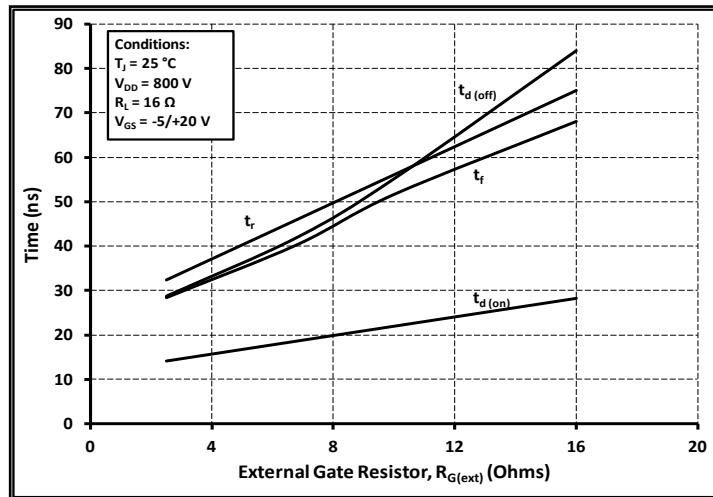


Figure 27. Switching Times vs.  $R_{G(\text{ext})}$

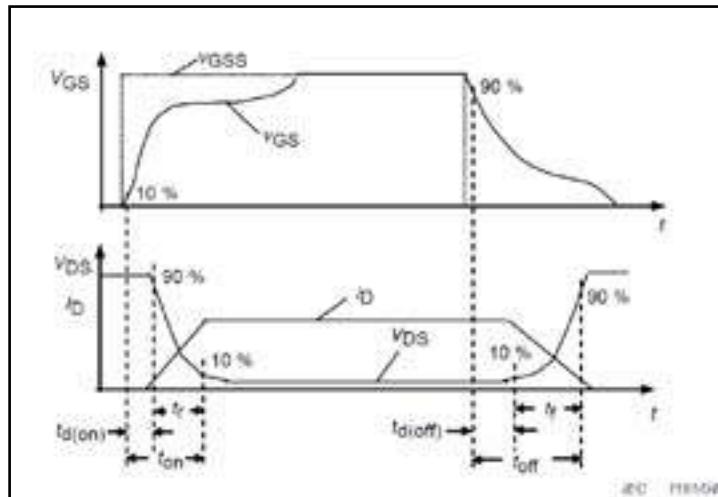


Figure 28. Switching Times Definition

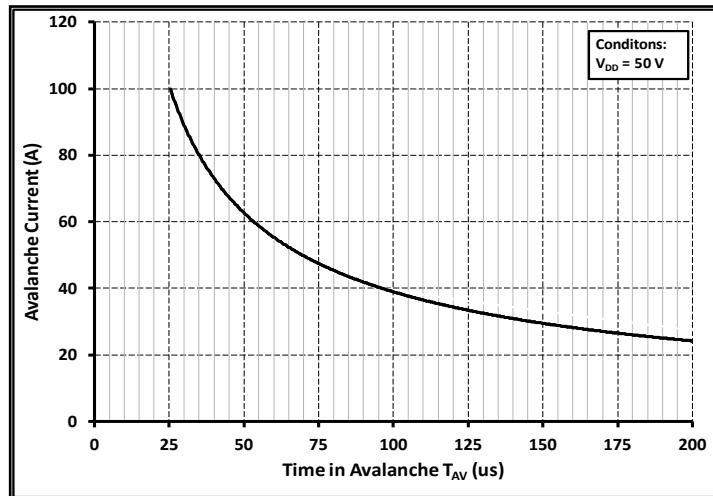


Figure 29. Single Avalanche SOA curve

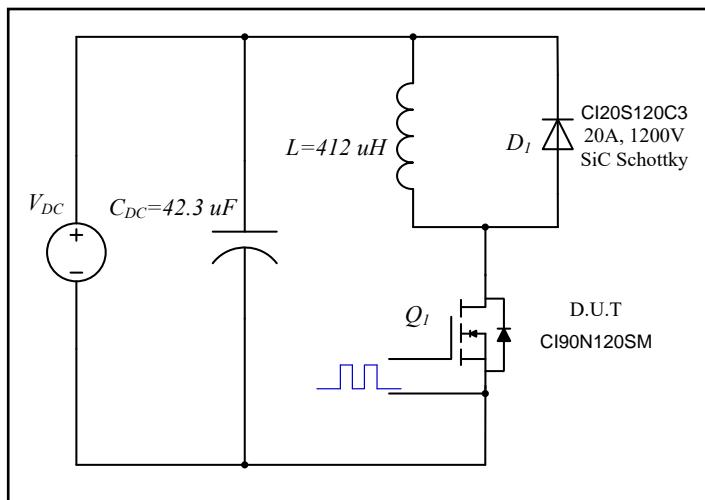
**Test Circuit Schematic**

Figure 30. Clamped Inductive Switching  
Waveform Test Circuit

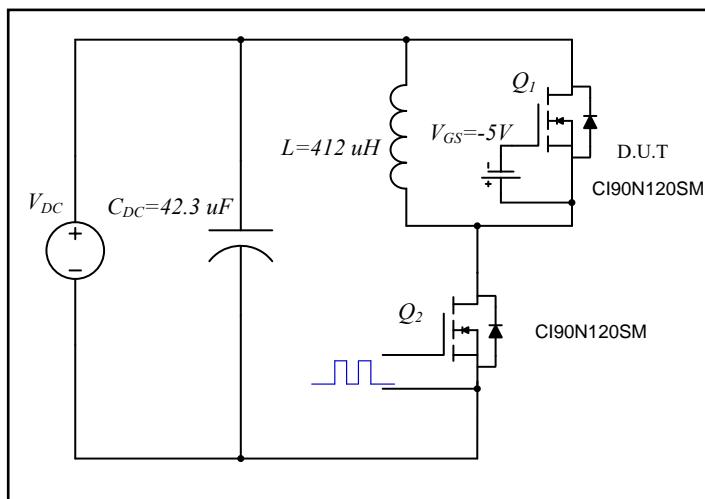
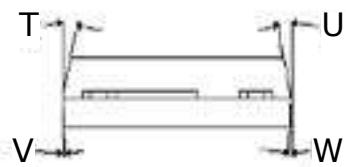
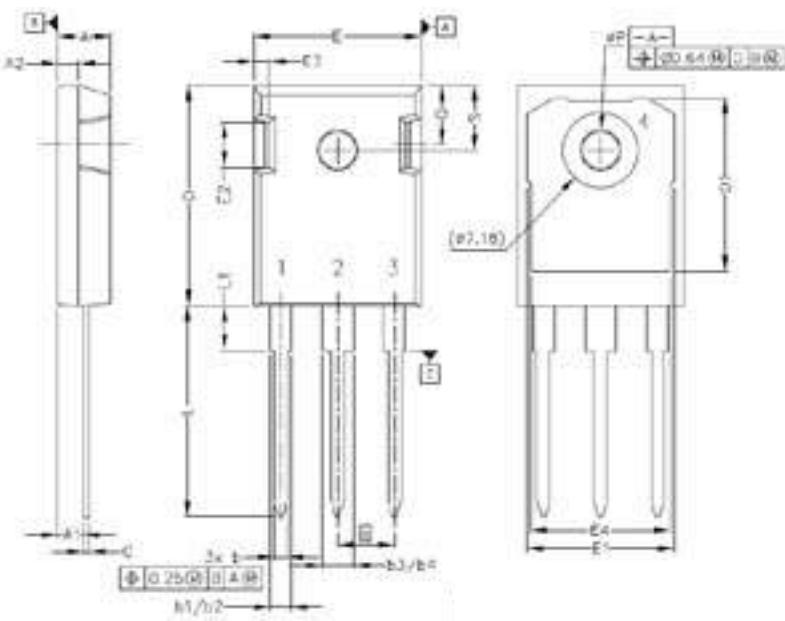


Figure 31. Body Diode Recovery Test Circuit

## Package Dimensions

Package TO-247-3



Pinout Information:

- Pin 1 = Gate
- Pin 2, 4 = Drain
- Pin 3 = Source

POS	Inches		Millimeters	
	Min	Max	Min	Max
A	.190	.205	4.83	5.21
A1	.090	.100	2.29	2.54
A2	.075	.085	1.91	2.16
b	.042	.052	1.07	1.33
b1	.075	.095	1.91	2.41
b2	.075	.085	1.91	2.16
b3	.113	.133	2.87	3.38
b4	.113	.123	2.87	3.13
c	.022	.027	0.55	0.68
D	.819	.831	20.80	21.10
D1	.640	.695	16.25	17.65
D2	.037	.049	0.95	1.25
E	.620	.635	15.75	16.13
E1	.516	.557	13.10	14.15
E2	.145	.201	3.68	5.10
E3	.039	.075	1.00	1.90
E4	.487	.529	12.38	13.43
e	.214 BSC		5.44 BSC	
N	3		3	
L	.780	.800	19.81	20.32
L1	.161	.173	4.10	4.40
ØP	.138	.144	3.51	3.65
Q	.216	.236	5.49	6.00
S	.238	.248	6.04	6.30
T	9°	11°	9°	11°
U	9°	11°	9°	11°
V	2°	8°	2°	8°
W	2°	8°	2°	8°